

Notice of References Cited

Application/Control No.

10/672,225

Applicant(s)/Patent Under
Reexamination
ALFERIEV ET AL.

Examiner

David J. Venci

Art Unit

1641

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,020,457	02-2000	Klimash et al.	528/373
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 96/07676	03-1996	WIPO	EKAGEN CORP.	C08F 8/34
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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